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#### EVENT CALENDAR

**Experimental Biology**  
April 5 - 9  
San Diego, CA

**Symposium Frontiers in Microscopy**  
April 14 - 16  
Munich, Germany

**The Confab**  
May 18 - 21  
Las Vegas, NV

**Scandem**  
June 2 - 4  
Lyngby, Denmark

- [See the Events Calendar](#)

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### Introducing the new Titan Krios™ TEM

The new Titan Krios has been optimized for cryo-transmission electron microscopy, automated single particle analysis, 2D electron crystallography and dual-axis tomography, enabling breakthroughs in biology and life sciences.

- > [Learn more about the Titan Krios TEM](#)
- > [Register for a one-day symposium to mark the inauguration of the new FEI Titan Krios TEM at the Max Planck Institute of Biochemistry in Martinsried, Germany](#)

### Discover the new Quanta™ Morphology SEM for Particle Analysis

Quanta Morphologi combines the magnification and resolving power of the FEI Quanta 200 FEG scanning electron microscope (SEM) with established particle analysis software from Malvern Instruments to provide a turn-key solution for particle characterization

- > [Learn more about Particle Analysis and the Quanta Morphology SEM](#)

### Rewiring Chips with FIB Circuit Edit

As geometries shrink, editing smaller circuits requires more precise FIB imaging and machining. Attend this 30 minute web cast and learn from FEI's leading circuit edit experts how the latest FIB technologies and techniques address these important challenges.

- > [Register now](#)

### Turning Mineral Analysis into Profit

The Mineral Liberation Analyzer (MLA) solution, jointly developed by FEI and JKTech, provides quantitative analysis of mineral and material samples. The power of scanning electron microscope technology is unlocked to perform targeted mineralogical analyses automatically.

- > [Learn more about FEI's MLA solution](#)

### FEI Company Reports Fourth-Quarter Financial Results

FEI Company reported 2007 annual revenue that was 24% higher and net income that was nearly three times greater than in 2006. Fourth quarter revenue grew both sequentially and year-over-year, as did quarterly net income, which was aided in the latest quarter by a tax benefit.

[> Read the Press Release](#)



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